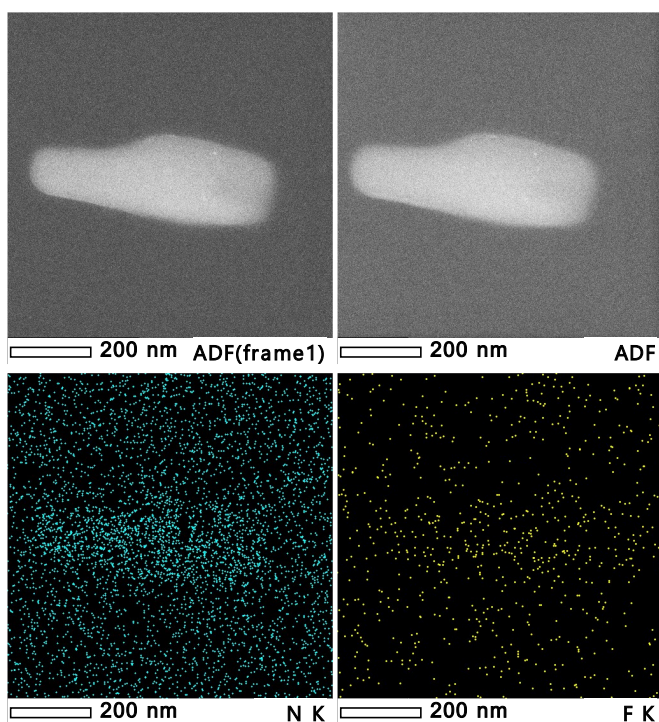
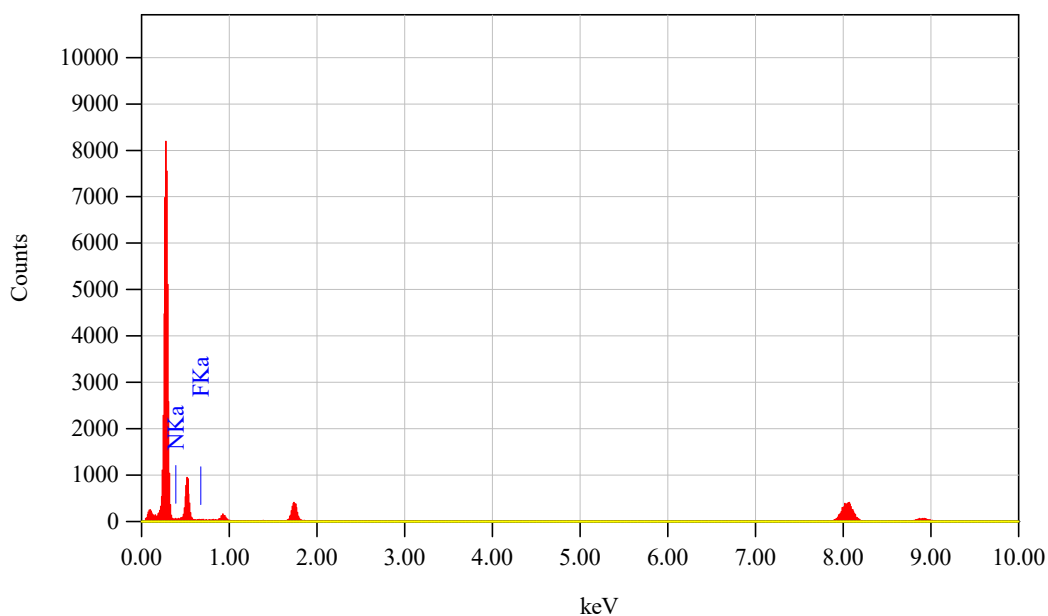


View001

JEOL 1/1



Date	: 3/21/2026
Resolution	: 512 x 512
-----	
Instrument	: JEM-F200 (U
Acc. Volt.	: 200 kV
Magnification	: x 250,000
Dwell Time	: 0.01 msec.
Sweep Count	: 42



Acquisition Parameter  
 Instrument : JEM-F200 (URP)  
 Acc. Voltage : 200.0 kV  
 Probe Current: 7.47500 nA  
 PHA mode : T4  
 Real Time : 110.03 sec  
 Live Time : 108.05 sec  
 Dead Time : 1 %  
 Counting Rate: 738 cps  
 Energy Range : 0 - 40 keV

Thin Film Standardless Standardless Quantitative Analysis

Fitting Coefficient : 0.9991

Element	(keV)	Mass%	Counts	Sigma	Atom%	Compound	Mass%	Cation	K
N K		ND			ND				
F K (Ref.)	0.677	100.00	203.47	10.46	100.00				1.0000
Total		100.00			100.00				